

Search Notes

Application/Control No.

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Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

LAIL ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
Search	Updated	7/06	hnh

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
385	100	7/06	hnh
385	102	✓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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Interference Text Search Done	11/05	hnh